

**Search Notes**

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Joon H. Hwang

Applicant(s)/Patent under  
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DEGUCHI ET AL.

Art Unit

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**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Palm See search history printout(s)	9/1/2005	JH